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June 2015

# **FDMD8260LET60**

# Dual N-Channel Power Trench<sup>®</sup> MOSFET 60 V. 5.8 m $\Omega$

### **Features**

- Extended T<sub>J</sub> Rating to 175 °C
- Max  $r_{DS(on)}$  = 5.8 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 15 A
- Max  $r_{DS(on)}$  = 8.7 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 12 A
- Ideal for Flexible Layout in Primary Side of Bridge Topology
- 100% UIL Tested
- Kelvin High Side MOSFET Drive Pin-out Capability
- Termination is Lead-free and RoHS Compliant

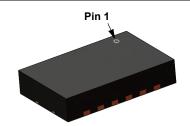


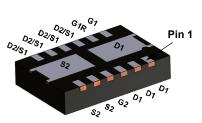
## **General Description**

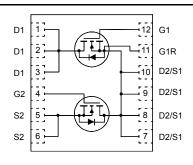
This device includes two 60V N-Channel MOSFETs in a dual Power (3.3 mm X 5 mm) package. HS source and LS Drain internally connected for half/full bridge, low source inductance package, low  $r_{DS(on)}/Qg$  FOM silicon.

## **Applications**

- Synchronous Buck : Primary Switch of Half / Full bridge Converter for Telecom
- Motor Bridge: Primary Switch of Half / Full bridge Converter for BLDC Motor
- MV POL: 48V Synchronous Buck Switch







Power 3.3 x 5

# MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted.

Symbol	Param	eter		Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage			60	V
V <sub>GS</sub>	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T <sub>C</sub> = 25 °C	(Note 5)	67	
	-Continuous	T <sub>C</sub> = 100 °C	(Note 5)	47	^
ID	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	15	Α
	-Pulsed		(Note 4)	304	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	181	mJ
	Power Dissipation	T <sub>C</sub> = 25 °C		44	
$P_D$	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.5	W
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1b)	1.1	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperation	ature Range		-55 to +175	°C

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.4	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a	60	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b	130	

## **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8260LT	FDMD8260LET60	Power 3.3 x 5	13 "	12 mm	3000 units

# **Electrical Characteristics** T<sub>J</sub> = 25 °C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
Off Characteristics							
$BV_{DSS}$	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	60			V	
$\Delta BV_{DSS} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25 °C		33		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V			1	μА	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±100	nA	

### On Characteristics

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.5	3.0	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 μA, referenced to 25 °C		-6		mV/°C
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		4.5	5.8	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 12 \text{ A}$		6.6	8.7	mΩ
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 125 °C		5.9	7.8	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DD</sub> = 5 V, I <sub>D</sub> = 15 A		56		S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V - 20 V V - 0 V		3745	5245	pF
Coss	Output Capacitance	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V If = 1 MHz		558	785	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 1/11/12		22	50	pF
R <sub>g</sub>	Gate Resistance		0.1	3.0	6.0	Ω

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		12	21	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 15 A	10	20	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$	47	74	ns
t <sub>f</sub>	Fall Time		11	20	ns
0	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	49	68	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to 5 V}$ $V_{DD} = 30 \text{ V}$	25	35	nC
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 15 A	8.6		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		5.2		nC

## **Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Dioge Forward Voltage	$V_{GS} = 0 V, I_S = 15 A$ (Note 2)	8.0	1.3	V
		$V_{GS} = 0 V, I_S = 1.6 A$ (Note 2)	0.7	1.2	
t <sub>rr</sub>	Reverse Recovery Time	- I <sub>E</sub> = 15 A. di/dt = 100 A/μs	36	58	ns
Q <sub>rr</sub>	Reverse Recovery Charge	T <sub>F</sub> = 15 A, di/dt = 100 A/μs	17	30	nC

NOTES

a. 60 °C/W when mounted on a 1 in² pad of 2 oz copper

b. 130 °C/W when mounted on a minimum pad of 2 oz copper

G PBS SS

G PRS SS

<sup>1.</sup> R<sub>BJA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>BJC</sub> is guaranteed by design while R<sub>BCA</sub> is determined by the user's board design.

<sup>2.</sup> Pulse Test: Pulse Width < 300  $\mu\text{s},$  Duty cycle < 2.0 %.

<sup>3.</sup> E<sub>AS</sub> of 181 mJ is based on starting T<sub>J</sub> = 25  $^{o}$ C, L = 3 mH, I<sub>AS</sub> = 11 A, V<sub>DD</sub> = 60 V, V<sub>GS</sub> = 10 V. 100% tested at L = 0.1 mH, I<sub>AS</sub> = 36 A.

<sup>4.</sup> Pulsed Id please refer to Fig 11 SOA graph for more details.

<sup>5.</sup> Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

# Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted.

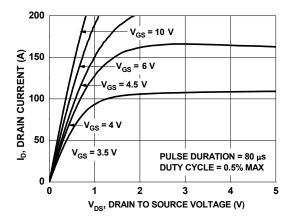


Figure 1. On-Region Characteristics

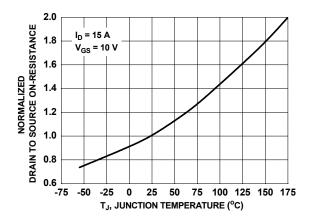


Figure 3. Normalized On Resistance vs. Junction Temperature

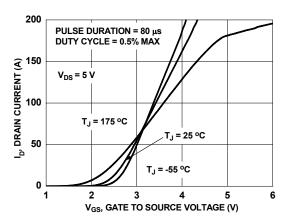


Figure 5. Transfer Characteristics

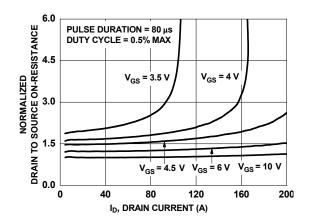


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

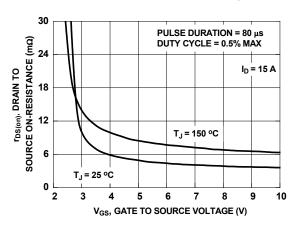


Figure 4. On Resistance vs. Gate to Source Voltage

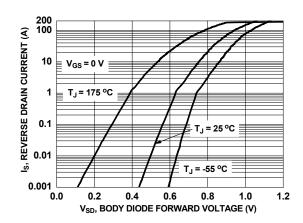


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

# **Typical Characteristics** $T_J = 25$ °C unless otherwise noted.

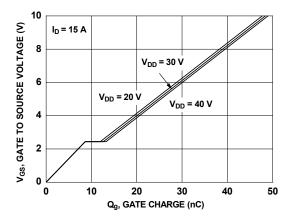


Figure 7. Gate Charge Characteristics

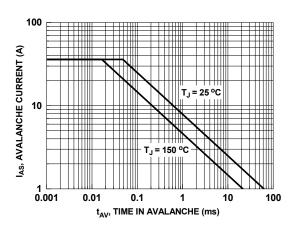


Figure 9. Unclamped Inductive Switching Capability

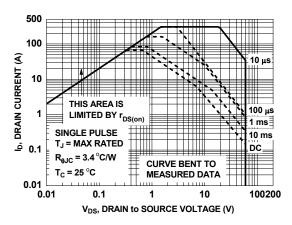


Figure 11. Forward Bias Safe Operating Area

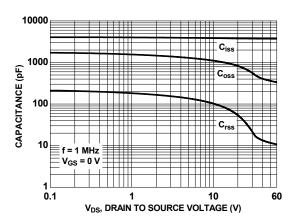


Figure 8. Capacitance vs. Drain to Source Voltage

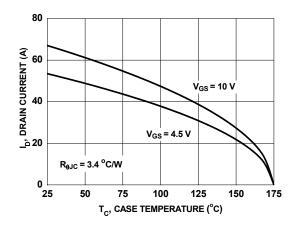


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

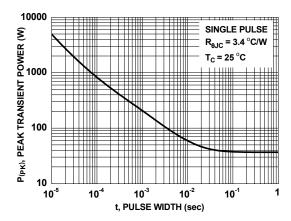


Figure 12. Single Pulse Maximum Power Dissipation



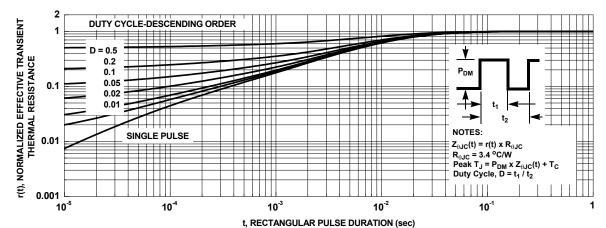
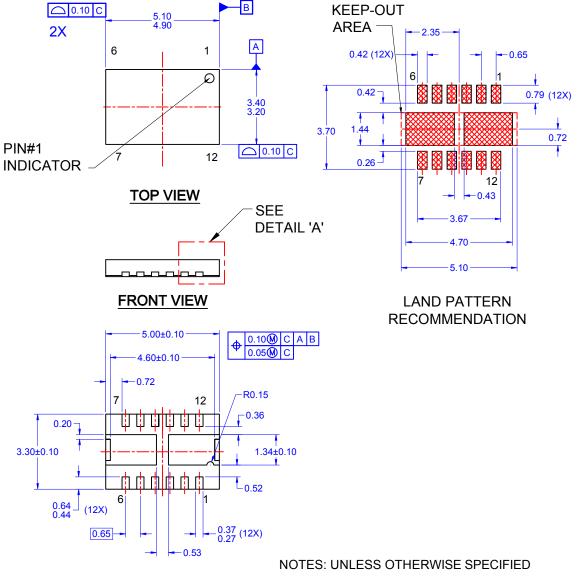


Figure 13. Junction-to-Case Transient Thermal Response Curve



# **BOTTOM VIEW**

0.80 0.70

| 0.10 | C | E |
| 0.25 | 0.05 | SEATING
| DETAIL 'A' | SCALE: 2:1

- A) DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229 DATED 8/2012
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F) DRAWING FILE NAME: MKT-PQFN12BREV1

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